FAIRCHILD SEMICONDUCTOR®

September 2008

FDMA1027PT

Dual P-Channel PowerTrench® MOSFET

–20 V, –3 A, 120 mΩ

Features

- Max $r_{DS(on)}$ = 120 mΩ at V_{GS} = -4.5 V, I_D = -3.0 A
- Max $r_{DS(on)}$ = 160 mΩ at V_{GS} = -2.5 V, I_D = -2.5 A
- Max $r_{DS(on)}$ = 240 mΩ at V_{GS} = -1.8 V, I_D = -1.0 A
- Low profile - 0.55 mm maximum - in the new package MicroFET 2x2 **Thin**
- RoHS Compliant

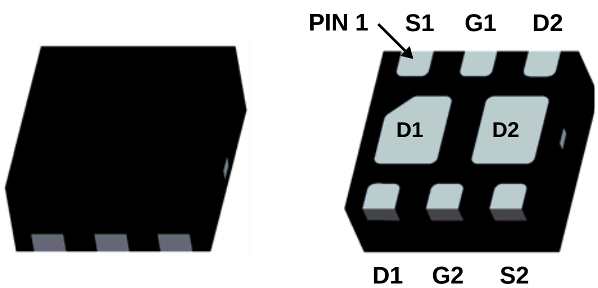
General Description

This device is designed specifically as a single package solution for the battery charge switch in cellular handset and other ultra-portable applications. It features two independent P-Channel MOSFETs with low on-state resistance for minimum conduction losses. When connected in the typical common source configuration, bi-directional current flow is possible.

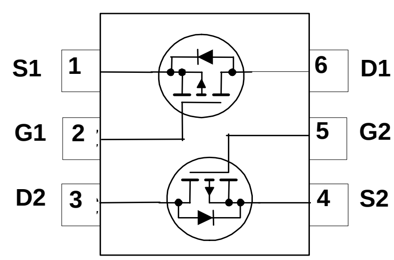
The MicroFET 2x2 **Thin** package offers exceptional thermal performance for it's physical size and is well suited to linear mode applications.

Applications

- Battery management
- Load switch
- Battery protection



MicroFET 2X2 Thin



MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter	Ratings	Units
V_{DS}	Drain to Source Voltage	-20	V
V_{GS}	Gate to Source Voltage	±8	V
I_D	Drain Current -Continuous T_A = 25 °C (Note 1a)	-3	A
	-Pulsed	-6	
P_D	Power Dissipation for Single Operation T_A = 25 °C (Note 1a)	1.4	W
	Power Dissipation for Single Operation T_A = 25 °C (Note 1b)	0.7	
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Single Operation) (Note 1a)	86	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Single Operation) (Note 1b)	173	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Dual Operation)	69	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Dual Operation)	151	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
27	FDMA1027PT	MicroFET 2x2 **Thin**	7 ”	8 mm	3000 units

Electrical Characteristics T_J = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units

Off Characteristics

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
BV_{DSS}	Drain to Source Breakdown Voltage	I_D = -250 μA, V_{GS} = 0 V	-20			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = -250 μA, referenced to 25 °C		-12		mV/°C
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = -16 V, V_{GS} = 0 V			-1	μA
I_{GSS}	Gate to Source Leakage Current	V_{GS} = ±8 V, V_{DS} = 0 V			±100	nA

On Characteristics

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
$V_{GS(th)}$	Gate to Source Threshold Voltage	V_{GS} = V_{DS}, I_D = -250 μA	-0.4	-0.7	-1.3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = -250 μA, referenced to 25 °C		2		mV/°C
$r_{DS(on)}$	Drain to Source On Resistance	V_{GS} = -4.5 V, I_D = -3.0 A		90	120	mΩ
		V_{GS} = -2.5 V, I_D = -2.5 A		120	160	
		V_{GS} = -1.8 V, I_D = -1.0 A		172	240	
		V_{GS} = -4.5 V, I_D = -3.0 A, T_J = 125 °C		118	160	
$I_{D(on)}$	On to State Drain Current	V_{GS} = -4.5 V, V_{DS} = -5 V	-20			A
g_{FS}	Forward Transconductance	V_{DS} = -5 V, I_D = -3.0 A		7		S

Dynamic Characteristics

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
C_{iss}	Input Capacitance	V_{DS} = -10 V, V_{GS} = 0 V, f = 1 MHz		435		pF
C_{oss}	Output Capacitance			80		pF
C_{rss}	Reverse Transfer Capacitance			45		pF

Switching Characteristics

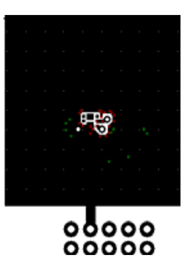
Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
$t_{d(on)}$	Turn-On Delay Time	V_{DD} = -10 V, I_D = -1.0 A, V_{GS} = -4.5 V, R_{GEN} = 6 Ω		9	18	ns
t_r	Rise Time			11	19	ns
$t_{d(off)}$	Turn-Off Delay Time			15	27	ns
t_f	Fall Time			6	12	ns
Q_g	Total Gate Charge	V_{DD} = -10 V, I_D = -3.0 A, V_{GS} = -4.5 V		4	6	nC
Q_{gs}	Gate to Source Gate Charge			0.8		nC
Q_{gd}	Gate to Drain “Miller” Charge			0.9		nC

Drain-Source Diode Characteristics

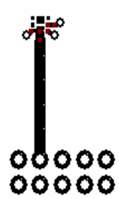
Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
I_S	Maximum continuous Drain-Source Diode Forward Current				-1.1	A
V_{SD}	Source to Drain Diode Forward Voltage	V_{GS} = 0 V, I_S = -1.1 A (Note 2)		-0.8	-1.2	V
t_{rr}	Reverse Recovery Time	I_F = -3.0 A, di/dt = 100 A/μs		17		ns
Q_{rr}	Reverse Recovery Charge			6		nC

Notes:

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in^2 pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a. 86 °C/W when mounted on a 1 in^2 pad of 2 oz copper.



b. 173 °C/W when mounted on a minimum pad of 2 oz copper.

2. Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0%.

Typical Characteristics T_J = 25 °C unless otherwise noted

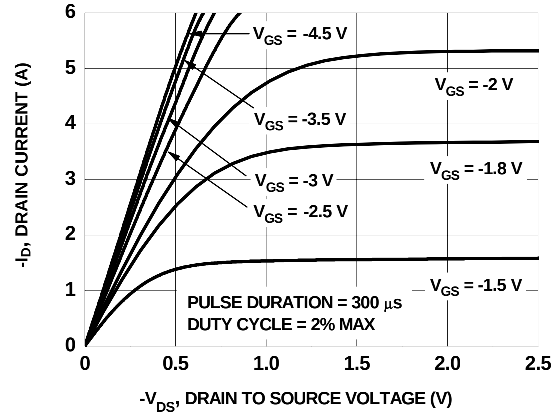


Figure 1. On Region Characteristics

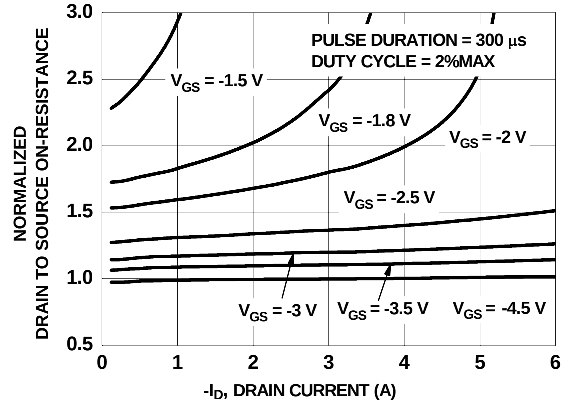


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

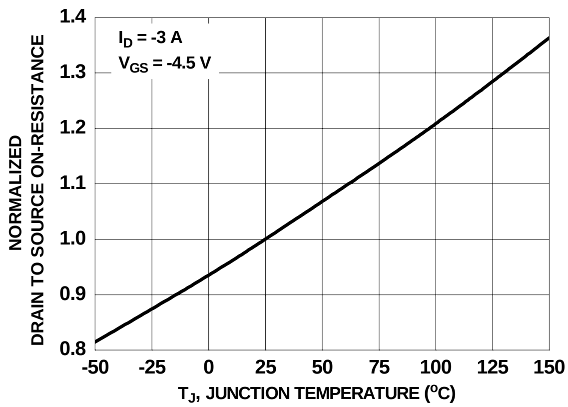


Figure 3. Normalized On Resistance vs Junction Temperature

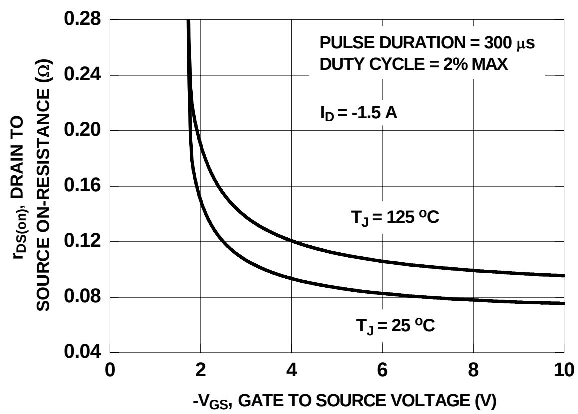


Figure 4. On-Resistance vs Gate to Source Voltage

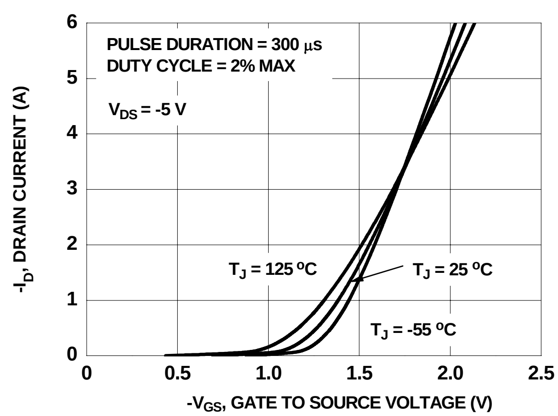


Figure 5. Transfer Characteristics

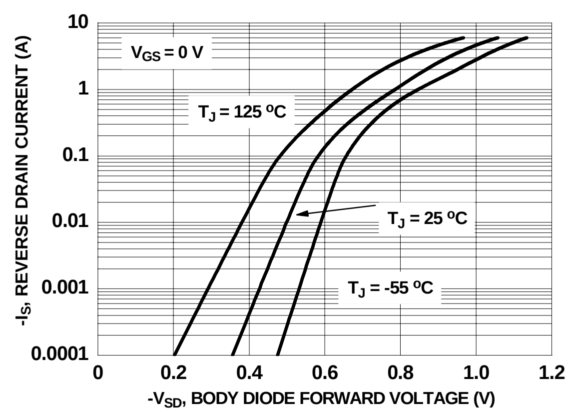


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25 °C unless otherwise noted

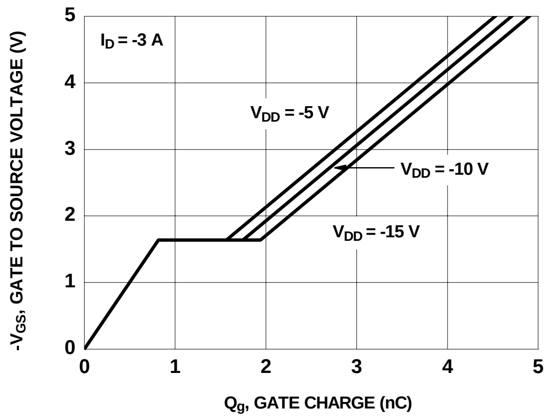


Figure 7. Gate Charge Characteristics

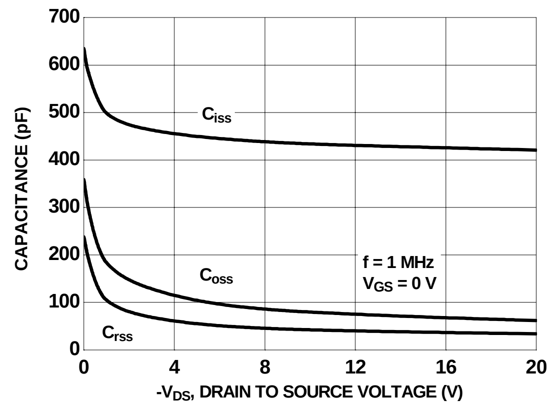


Figure 8. Capacitance vs Drain to Source Voltage

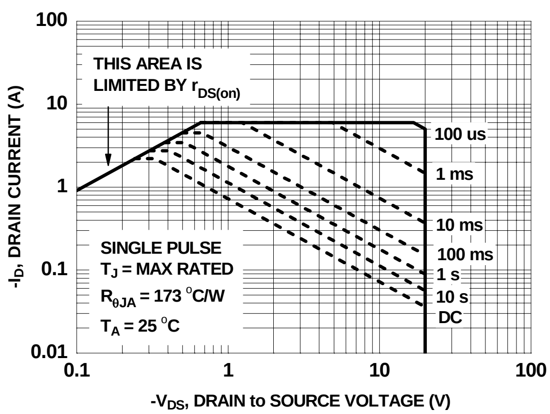


Figure 9. Forward Bias Safe Operating Area

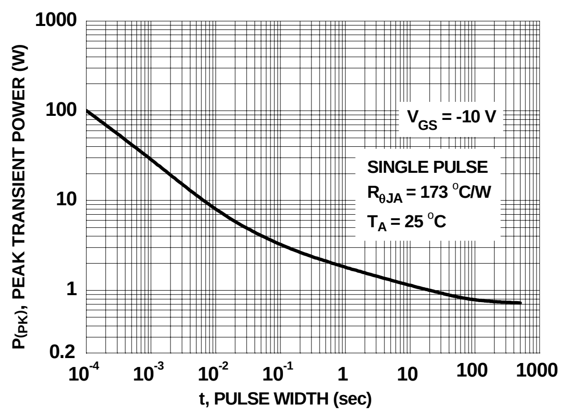


Figure 10. Single Pulse Maximum Power Dissipation

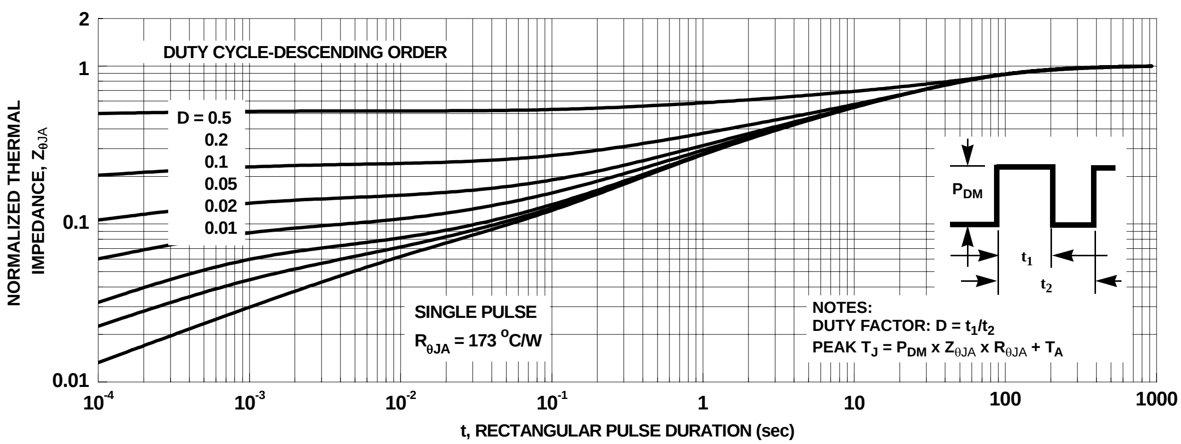
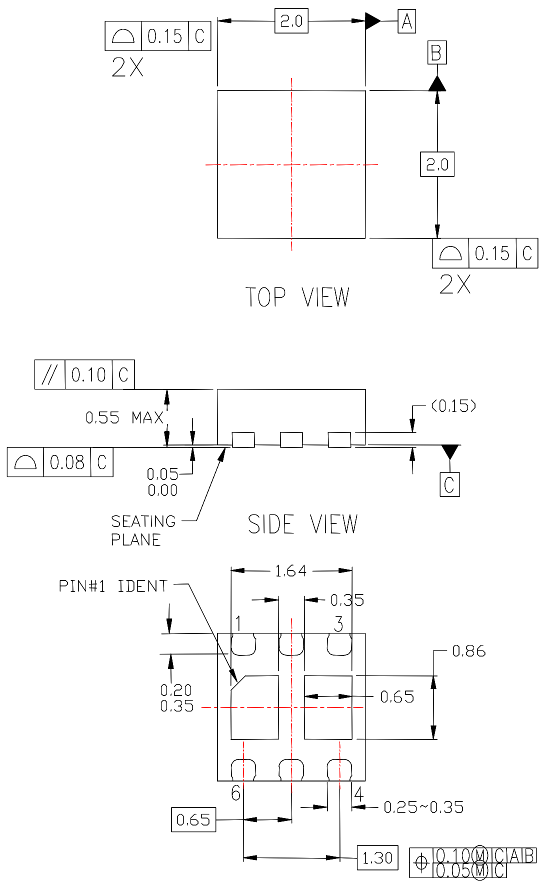
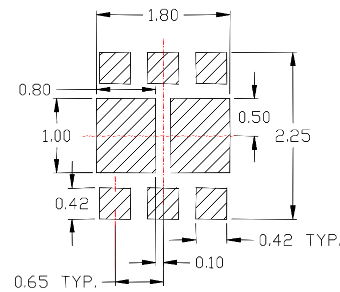


Figure 11. Junction-to-Ambient Transient Thermal Response Curve

Dimensional Outline and Pad Layout



BOTTOM VIEW



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